

Supplementary Materials for
**Neuromorphic learning, working memory, and metaplasticity in
nanowire networks**

Alon Loeffler *et al.*

Corresponding author: Alon Loeffler, aloe8475@sydney.edu.au; Adrian Diaz-Alvarez, adrianlocdiaz@gmail.com;
Zdenka Kuncic, zdenka.kuncic@sydney.edu.au

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The PDF file includes:

Supplementary Text
Figs. S1 to S7
Legends for movies S1 to S4
Legend for Source Data File S1

Other Supplementary Material for this manuscript includes the following:

Movies S1 to S4
Source Data File S1

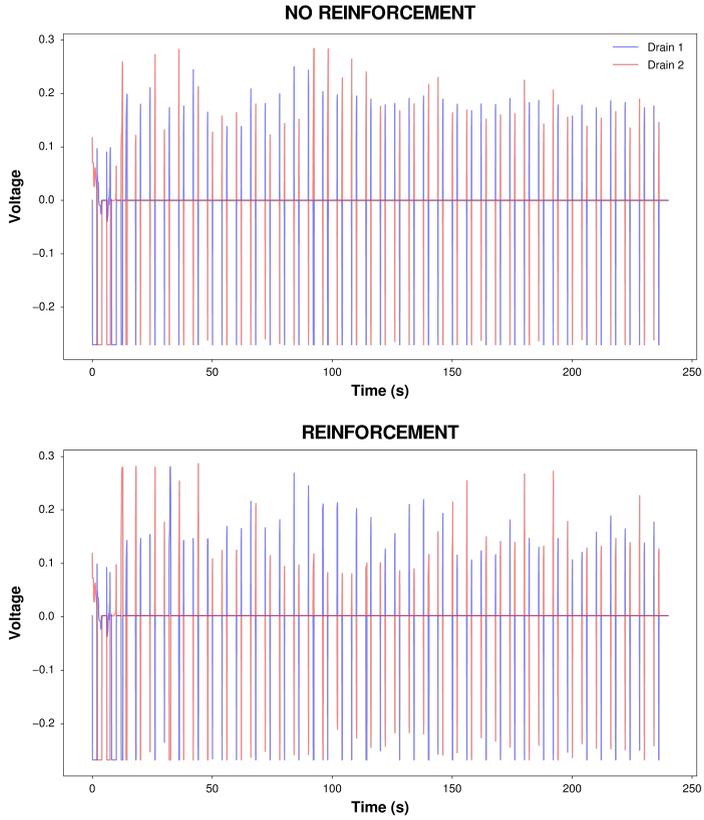


Fig. S1 Voltage readouts for drain 1 (blue) and drain 2 (red) during simple binary classification (Task 1) in simulation. The gradient descent-like algorithm introduced in Algorithm 1 of the main text adjusts drain voltage in order to match current output to reach θ (cf. Figure 2 of main text).

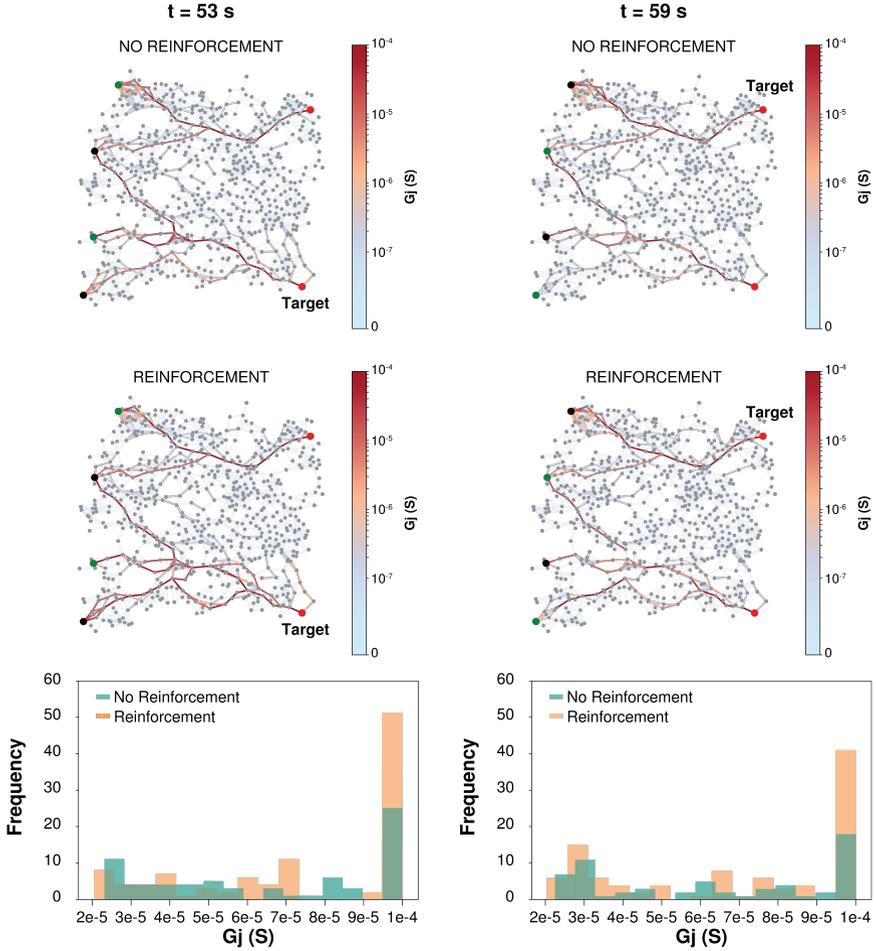


Fig. S2 Network connectivity maps and junction conductance (G_j) histograms for Figure 2 of the main text). Left column: $t = 53$ s; right column: $t = 59$ s. The difference in junction conductance for networks with (orange) and without (green) reinforcement is highlighted by histograms.

Simulation junction filament decay rate (b)

The filament decay parameter b was varied from very low ($b = 0.1$) to high ($b = 5$) and the average junction conductance (G_j) was recorded across all 2582 junctions at each timestep. The goal of this was to better constrain this parameter from the experimental measurements using working memory. 7 inputs were used with 2 drains, with placements identical to Tasks 1 and 2. Voltage was set at $V_i = 0.3$ V for the first 30 s and then reset to zero for the final 70 seconds. All 7 inputs and 2 drains were opened.

As Figure S3 shows, higher b values resulted in significantly faster decay, with G_j in both $b = 5$ and $b = 2$ resetting to zero, approximately 2 and 4 seconds after V_i was reset to zero, respectively. In contrast, low filament decay parameters took longer to decay, with $b = 0.1$ taking over 50 seconds to fully reset after V_i was reset to zero. It is important to note that b cannot be controlled experimentally, other than, for example, by varying properties such as the physical size of the inductive PVP layer between silver nanowires in an Ag-PVP NWN. However, the experimental filament decay rate is significantly lower than even $b = 0.1$, sometimes taking over 24 hours to fully reset.

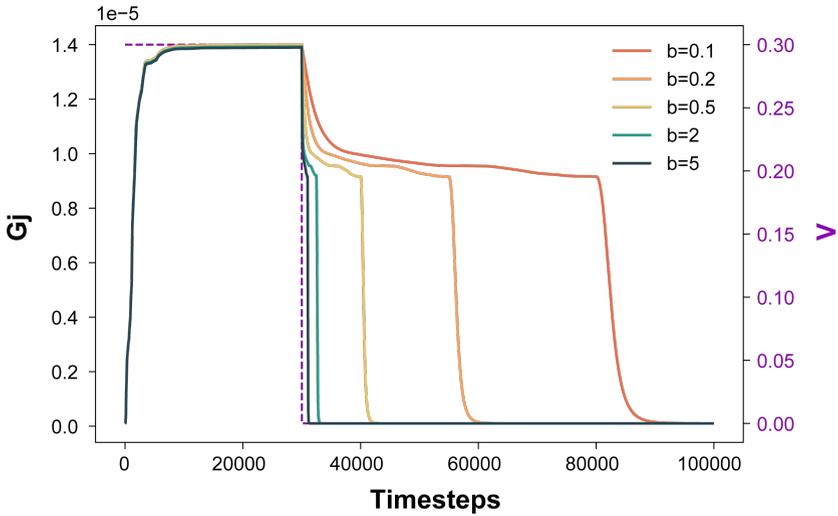


Fig. S3 Average junction conductance (G_j ; left axis) for varying filament decay parameter values (b) in simulation. The dotted purple line is the input voltage (V ; right axis), which is set to 0.3 V for 3000 timesteps, and reset to 0 V for the rest of the simulation. For higher b values (e.g. $b = 5$), average junction conductance drops to zero more quickly than for lower b values (e.g. $b = 0.5$).

Varying decay rate b for tasks 2 and 3

To demonstrate the effect of varying filament decay rate, b , we repeated Task 2 with five b values (0.1, 0.2, 0.5, 2 and 5). Figure S4 shows change in accuracy as n is increased from 2 to 6, with varying b values. This is for the no-reinforcement condition. $b = 0.5$ was chosen in the main text for clarity of visualisation across all tasks.

We repeated this for Task 3, with n ranging from 1 to 7 (cf. Figure S5).

Network connectivity with varying b

In Figure 5 of the main text, network connectivity maps are shown comparing pathway formation for simulated NWNs with and without reinforcement. For

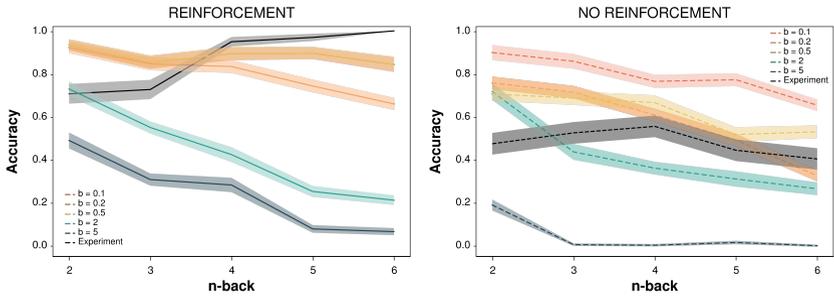


Fig. S4 Accuracy vs n -back for Task 2 with varying b values, with and without reinforcement.

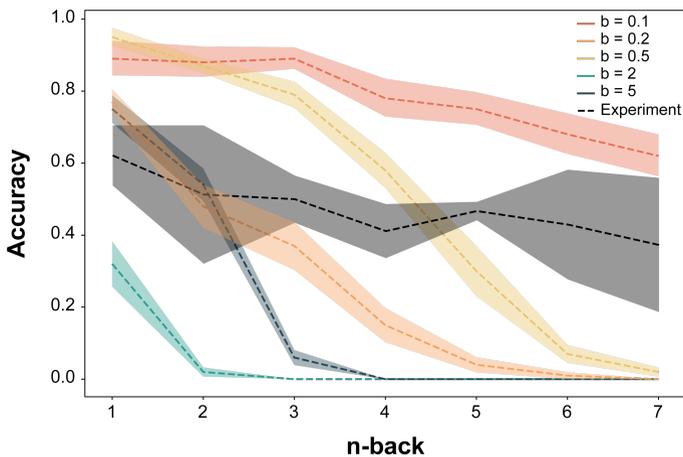


Fig. S5 Accuracy vs n -back for Task 3 with varying b values without reinforcement. The black line represents the mean accuracy of the experimental no-reinforcement condition, as a reference point.

that figure, $b = 2$ was used for clarity of visualisation. However, the results shown for Task 3 (Figure 4) were for those with $b = 0.5$. Supplementary Figure S6 shows pathways for $b = 0.5$.

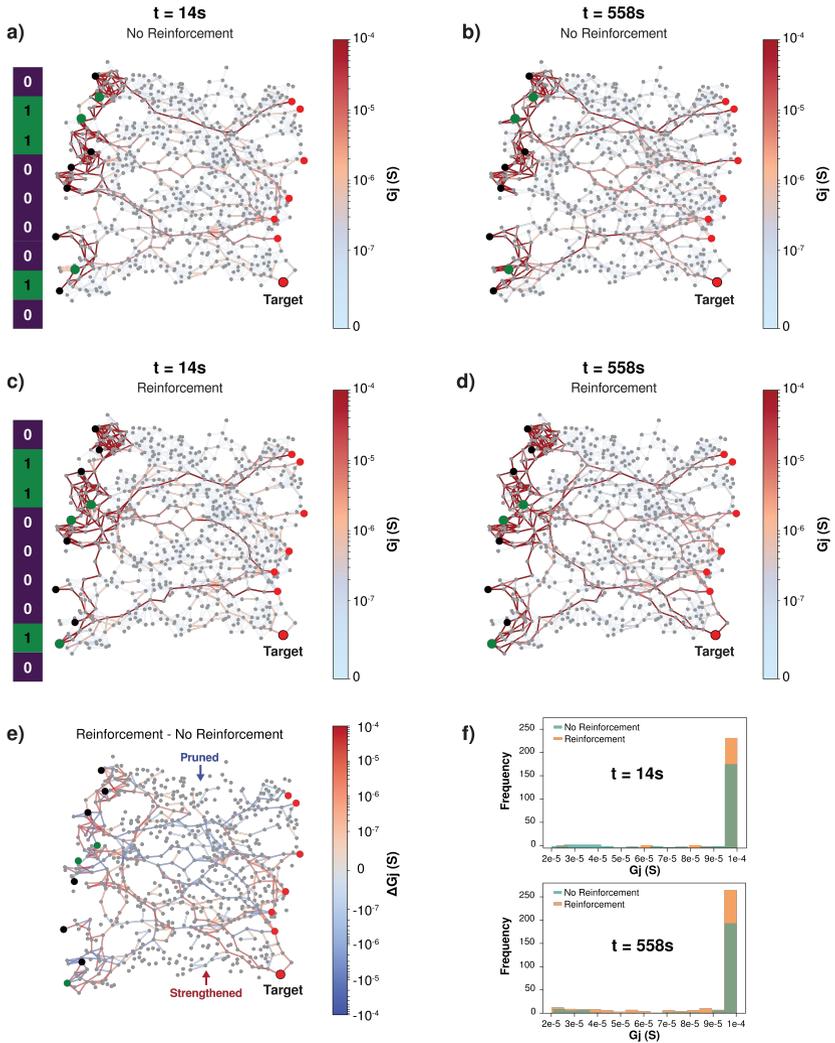


Fig. S6 Simulated nanowire network connectivity snapshots during memory recall. a) & b) Network connectivity maps visualising junction conductance (G_j) snapshots at early ($t = 14\text{ s}$, epoch 1/70) and middle ($t = 558\text{ s}$, epoch 36/70) testing periods of the WM n -back task (with $n = 3$), respectively, without reinforcement. Active and inactive source electrodes are highlighted in green and black, respectively, with active drain electrodes in red and target drain indicated. c) & d) Same as a) and b), but with reinforcement. e) Topological reconfiguration map highlighting the junction conductance change ΔG_j between reinforced and non-reinforced paths. Values are calculated by comparing functional maps as follows: $(d - c) - (b - a)$. Here, the effect of PRL is less visually clear, but still significant. f) G_j histograms corresponding to a) & c) (top panel), and b) & d) (bottom panel). For clarity, G_j is thresholded at $2 \times 10^{-5}\text{ S}$. Here, filament decay, $b = 0.5$.

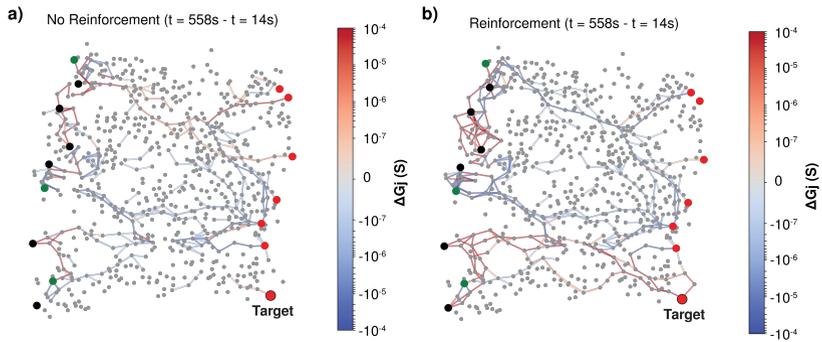


Fig. S7 Topological reconfiguration maps used to calculate Figure 5e in main text. a) Synaptic pathway strengthening (red) and pruning (blue) between $t = 14\text{s}$ and $t = 558\text{s}$ for no-reinforcement. **b)** Same as a) but for reinforcement. As in the main text, $b = 2$ for clarity of visualisation.

Movie. S1 Movie of Task 3 with No Reinforcement for $b = 0.5$.

Movie. S2 Movie of Task 3 with Reinforcement for $b = 0.5$.

Movie. S3 Movie of Task 3 with No Reinforcement for $b = 2$.

Movie. S4 Movie of Task 3 with Reinforcement for $b = 2$.

Data. S1 Source Data for Experimental Measurements.